

ON Semiconductor®

FQB7N60 / FQI7N60

N-Channel QFET® MOSFET

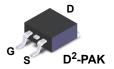
600 V, 7.4 A, 1.0 Ω

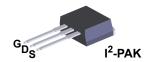
Description

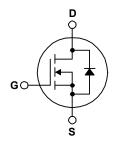
This N-Channel enhancement mode power MOSFET is produced using ON Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 7.4 A, 600 V, $R_{DS(on)}$ = 1.0 Ω (Max.) @V_{GS} = 10 V, I_D = 3.7 A
- Low Gate Charge (Typ. 29 nC)
- Low Crss (Typ. 16 pF)
- 100% Avalanche Tested







Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

| Symbol | Parameter | | FQB7N60TM FQB7N60TM-WS FQI7N60TU | Unit | |
|-----------------------------------|--|----------|--|------|--|
| V _{DSS} | Drain-Source Voltage | | 600 | V | |
| I _D | Drain Current - Continuous (T _C = 25° | °C) | 7.4 | А | |
| | - Continuous (T _C = 100°C) | | 4.7 | А | |
| I _{DM} | Drain Current - Pulsed | (Note 1) | 29.6 | А | |
| V _{GSS} | Gate-Source Voltage | | ± 30 | V | |
| E _{AS} | Single Pulsed Avalanche Energy | (Note 2) | 580 | mJ | |
| I _{AR} | Avalanche Current | (Note 1) | 7.4 | Α | |
| E _{AR} | Repetitive Avalanche Energy (Note | | 14.2 | mJ | |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | 4.5 | V/ns | |
| P_{D} | Power Dissipation (T _A = 25°C) * | | 3.13 | W | |
| | Power Dissipation (T _C = 25°C) | | 142 | W | |
| | - Derate above 25°C | | 1.14 | W/°C | |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C | |
| TL | Maximum Lead Temperature for Solderin 1/8" from Case for 5 Seconds | ng, | 300 | °C | |

Thermal Characteristics

| Symbol | Parameter | FQB7N60TM FQB7N60TM-WS FQI7N60TU | Unit | | |
|-----------------|---|--|----------|--|--|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 0.88 | | | |
| В | Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max. | 62.5 | °C/W | | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max. | 40 | <u> </u> | | |

29

7

14.5

(Note 4)

38

nC

nC

nC

Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|--------------|----------|---------------------|----------------|-----------|------------|-----------|
| FQB7N60TM | FQB7N60 | D ² -PAK | Tape and Reel | 330 mm | 24 mm | 800 units |
| FQB7N60TM-WS | FQB7N60S | D ² -PAK | Tape and Reel | 330 mm | 24 mm | 800 units |
| FQI7N60TU | FQI7N60 | I ² -PAK | Tube | N/A | N/A | 50 units |

Electrical Characteristics T_C = 25°C unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|------------------------------------|--|---|------|------|------|------|
| Off Cha | aracteristics | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 600 | | | V |
| ΔBV_{DSS} / ΔT_{J} | Breakdown Voltage Temperature Coefficient | I _D = 250 μA, Referenced to 25° | C | 0.67 | | V/°C |
| I _{DSS} | Zoro Cata Valtago Drain Current | V _{DS} = 600 V, V _{GS} = 0 V | | | 10 | μΑ |
| | Zero Gate Voltage Drain Current | V _{DS} = 480 V, T _C = 125°C | | | 100 | μΑ |
| I _{GSSF} | Gate-Body Leakage Current, Forward | V _{GS} = 30 V, V _{DS} = 0 V | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | V _{GS} = -30 V, V _{DS} = 0 V | | | -100 | nA |
| | racteristics | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 3.0 | | 5.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = 10 \text{ V}, I_D = 3.7 \text{ A}$ | | 0.8 | 1.0 | Ω |
| 9 _{FS} | Forward Transconductance | V _{DS} = 50 V, I _D = 3.7 A | | 6.4 | | S |
| • | ic Characteristics | | | 1400 | 1 | |
| C _{iss} | Input Capacitance | $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz | | 1100 | 1430 | pF |
| C _{oss} | Output Capacitance | | | 135 | 175 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 16 | 21 | pF |
| Switchi | ing Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 300 V, I _D = 7.4 A, | | 30 | 70 | ns |
| t _r | Turn-On Rise Time | $R_G = 25 \Omega$ | | 80 | 170 | ns |
| t _{d(off)} | Turn-Off Delay Time | (Note 4) | | 65 | 140 | ns |
| t _f | Turn-Off Fall Time | | 4) | 60 | 130 | ns |

Drain-Source Diode Characteristics and Maximum Ratings

| | | • | | | | |
|-----------------|---|---|---|-----|------|----|
| Is | Maximum Continuous Drain-Source Diode Forward Current | | | | 7.4 | Α |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | - | | 29.6 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0 V, I _S = 7.4 A | - | | 1.4 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0 \text{ V, } I_{S} = 7.4 \text{ A,}$ | - | 320 | | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F / dt = 100 A/μs | - | 2.4 | | μC |

V_{GS} = 10 V

 V_{DS} = 480 V, I_{D} = 7.4 A,

 Q_g

Q_{gs}

 Q_{gd}

- 1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 19.5 mH, I_{AS} = 7.4 A, V_{DD} = 50 V, R_G = 25 Ω , starting T_J = 25°C. 3. I_{SD} ≤ 7.4 A, di/dt ≤ 200 A/ μ s, V_{DD} ≤ BV $_{DSS}$, starting T_J = 25°C. 4. Essentially independent of operating temperature.

Total Gate Charge

Gate-Source Charge

Gate-Drain Charge

Typical Characteristics

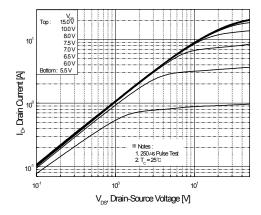
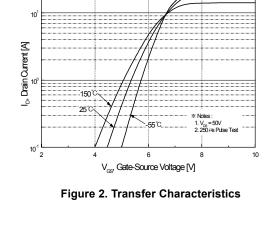


Figure 1. On-Region Characteristics



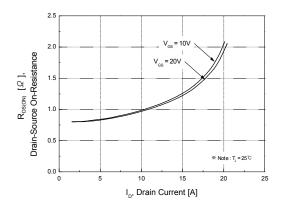


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

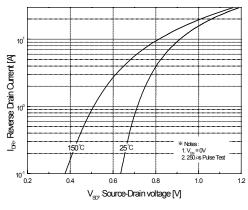


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

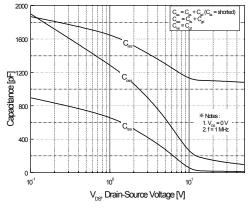


Figure 5. Capacitance Characteristics

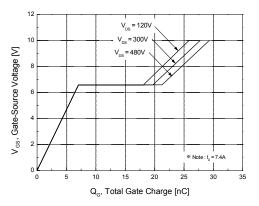


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

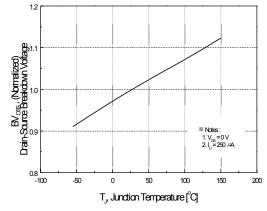


Figure 7. Breakdown Voltage Variation vs. Temperature

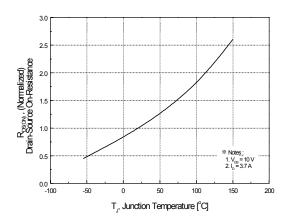


Figure 8. On-Resistance Variation vs. Temperature

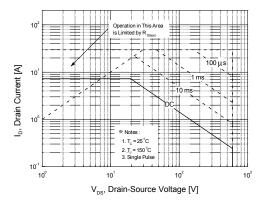


Figure 9. Maximum Safe Operating Area

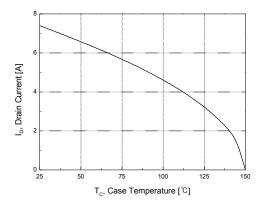


Figure 10. Maximum Drain Current vs. Case Temperature

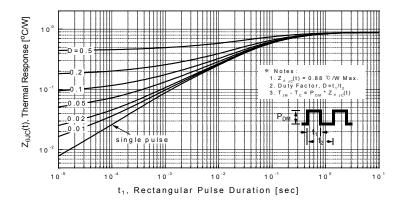


Figure 11. Transient Thermal Response Curve

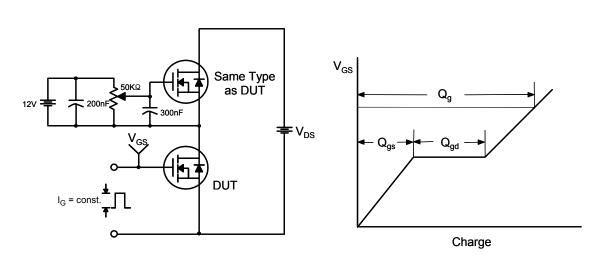


Figure 12. Gate Charge Test Circuit & Waveform

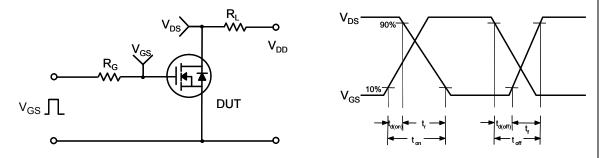


Figure 13. Resistive Switching Test Circuit & Waveforms

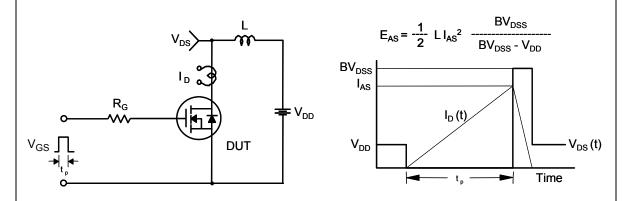
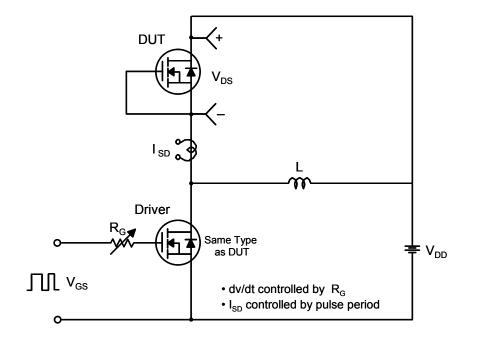


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



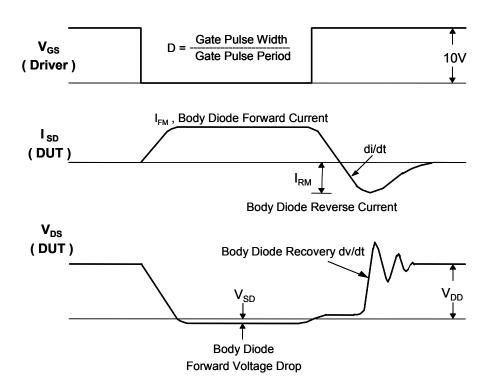


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

Mechanical Dimensions

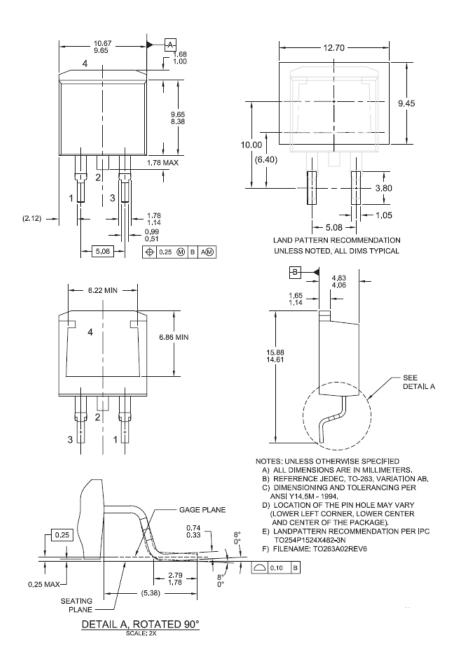
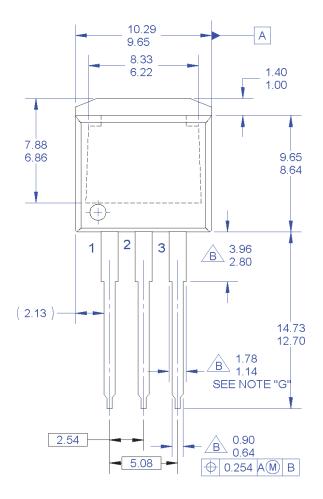
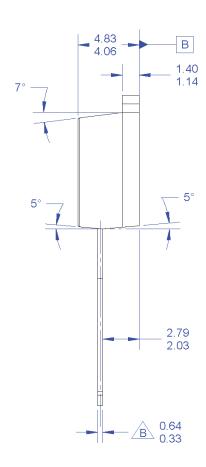


Figure 16. TO263 (D²PAK), Molded, 2-Lead, Surface Mount

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Mechanical Dimensions





NOTES:

A. EXCEPT WHERE NOTED CONFORMS TO
TO262 JEDEC VARIATION AA.

DOES NOT COMPLY JEDEC STD. VALUE.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DIMENSIONS ARE EXCLUSIVE OF BURRS.
MOLD FLASH AND TIE BAR PROTRUSIONS.
E. DIMENSION AND TOLERANCE AS PER ANSI
Y14.5-1994.
F. LOCATION OF PIN HOLE MAY VARY
(LOWER LEFT CORNER, LOWER CENTER
AND CENTER OF PACKAGE)
G. MAXIMUM WIDTH FOR F102 DEVICE = 1.35 MAX.
H. DRAWING FILE NAME: TO262A03REV5

Figure 17. TO262 (I²PAK), Molded, 3-Lead, Jedec Variation AA

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